# Si3454DV N-Channel PowerTrench<sup>®</sup> MOSFET

## **General Description**

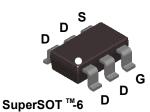
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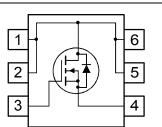
These N-Channel Logic Level MOSFETs are produced using Fairchild Semiconductor's advanced Power Trench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

These devices are well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.

# Features

- 4.2 A, 30 V.  $R_{DS(ON)} = 65 \text{ m}\Omega @ V_{GS} = 10 \text{ V}$  $R_{DS(ON)} = 95 \text{ m}\Omega @ V_{GS} = 4.5 \text{ V}$
- High performance trench technology for extremely low  $R_{\text{DS}(\text{ON})}$
- Low gate charge (9.4 nC typical)
- High power and current handling capability





# Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units		
V <sub>DSS</sub>	Drain-Source	ce Voltage		30	V	
V <sub>GSS</sub>	Gate-Source	ce Voltage		±20		
I <sub>D</sub>	Drain Curren	nt – Continuous (Note 1a)		4.2	A	
		<ul> <li>Pulsed</li> </ul>		20		
P <sub>D</sub>	Maximum Po	wer Dissipation	(Note 1a)	1.6	W	
			(Note 1b)	0.8		
		d Storage Junction T	emperature Range	-55 to +150	°C	
Therma	I Charact	eristics				
Therma R <sub>θJA</sub>	I Charact	eristics istance, Junction-to-A	Ambient (Note 1a)	78	°C/W	
Τ <sub>J</sub> , T <sub>STG</sub> <b>Therma</b> R <sub>θJA</sub> R <sub>θJC</sub>	I Charact	eristics	Ambient (Note 1a)			
<b>Therma</b> R <sub>θJA</sub> R <sub>θJC</sub>	I Charact Thermal Res	eristics istance, Junction-to-A istance, Junction-to-C	Ambient (Note 1a) Case (Note 1)	78	°C/W	
Therma <sub>R₀JA</sub> R₀JC Packag	I Charact Thermal Res	eristics istance, Junction-to-A istance, Junction-to-C	Ambient (Note 1a)	78	°C/W	

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Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics					
BV <sub>DSS</sub>	Drain–Source Breakdown Voltage	$V_{GS} = 0 V$ , $I_D = 250 \mu A$	30			V
ΔBV <sub>DSS</sub> ΔTJ	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, Referenced to 25°C		20		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V			1	μA
		V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> =70°C			25	1
I <sub>GSSF</sub>	Gate-Body Leakage, Forward	V <sub>GS</sub> = 20 V, V <sub>DS</sub> = 0 V			100	nA
I <sub>GSSR</sub>	Gate-Body Leakage, Reverse	V <sub>GS</sub> = -20 V, V <sub>DS</sub> = 0 V			-100	nA
On Char	acteristics (Note 2)	•				
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	1	1.5	2	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, Referenced to 25°C		- 4		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance	$V_{GS}$ = 10 V, $I_D$ = 4.2 A $V_{GS}$ = 4.5 V, $I_D$ = 3.4 A		33 44	65 95	mΩ
I <sub>D(on)</sub>	On–State Drain Current	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 5 V	15			Α
<b>g</b> <sub>FS</sub>	Forward Transconductance	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 4.2 \text{ A}$		10		S
	Characteristics			L	1	I
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 15 V, V_{GS} = 0 V,$		460		pF
Coss	Output Capacitance	f = 1.0  MHz		115		pF
C <sub>rss</sub>	Reverse Transfer Capacitance	-		45		pF
	g Characteristics (Note 2)			1	1	
t <sub>d(on)</sub>	Turn–On Delay Time	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 1 A,		5	20	nS
t <sub>r</sub>	Turn–On Rise Time	$V_{GS}$ = 10 V, $R_{GEN}$ = 6 $\Omega$		8	30	nS
t <sub>d(off)</sub>	Turn–Off Delay Time	4		17	35	nS
t <sub>f</sub>	Turn–Off Fall Time	1		13	20	nS
t <sub>rr</sub>	Source-Drain Reverse Recovery Time	I <sub>F</sub> = 1.7 A, di/dt = 100 A/uS			80	nS
Qg	Total Gate Charge	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 4.2 \text{ A},$		9.4	15	nC
Q <sub>gs</sub>	Gate–Source Charge	$V_{GS} = 10 V$		1.2		nC
Q <sub>gd</sub>	Gate–Drain Charge	7		1.1		nC
Drain-S	ource Diode Characteristics	and Maximum Ratings				
ls	Maximum Continuous Drain–Sourc	<b>v</b>			1.7	Α
V <sub>SD</sub>	Drain–Source Diode Forward Voltage	$V_{GS} = 0 V$ , $I_S = 1.7 A$ (Note 2)			1.2	V

Notes:

1.  $R_{0JA}$  is the sum of the junction-to-case and case-to-ambient resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{0JC}$  is guaranteed by design while  $R_{0CA}$  is determined by the user's board design.

a.  $~78^\circ\text{C/W}$  when mounted on a  $1\text{in}^2$  pad of 2oz copper on FR-4 board.

b. 156°C/W when mounted on a minimum pad.

2. Pulse Test: Pulse Width  $\leq$  300  $\mu s,$  Duty Cycle  $\leq$  2.0%

Typical Characteristics	Si3454DV	
Figure 1. On-Region Characteristics.	Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.	
Figure 3. On-Resistance Variation withTemperature.	Figure 4. On-Resistance Variation with Gate-to-Source Voltage.	
Figure 5. Transfer Characteristics.	Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.	

Typical Characteristics	
Figure 7. Gate Charge Characteristics.	Figure 8. Capacitance Characteristics.
Figure 9. Maximum Safe Operating Area.	Figure 10. Single Pulse Maximum Power Dissipation.
Figure 11. Transient Therma Thermal characterization performed us Transient thermal response will chang	Il Response Curve. sing the conditions described in Note 1c. e depending on the circuit board design.
	a appending on the circuit board design.

Si3454DV

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